

30V P-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

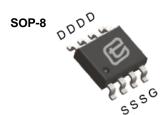
 V_{DS} -30V I_{D} (at V_{GS} =-10V) -6A

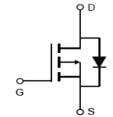
 $R_{DS(ON)}$ (at V_{GS} =-10V) < 50m Ω

 $R_{DS(ON)}$ (at V_{GS} =-4.5V) < 79m Ω

100% UIS Tested







Part Number	Package Type	Form	Marking
TTJ06P03AT	SOP-8	Tape&Reel	06P03AT

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	-30	V
Gate-Source Voltage		V _{GS}	±20	V
Ocation of David Comment B	T _C =25°C	- I _D	-6	Δ.
Continuous Drain Current B	T _C =100°C		-4.2	Α
Pulsed Drain Current ^A		I _{DM}	-24	Α
Avalanche Current A		I _{AS}	-4.8	Α
Single Pulse Avalanche Energy L =0.3mH A		E _{AS}	3.46	mJ
Dowar Discipation C	T _C =25°C	P _D	3	W
Power Dissipation ^C	T _C =100°C		1.5	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C
Thermal Characteristics				

Thermal Characteristics

Parameter		Symbol	Maximum	Units
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	50	00.004
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	64	°C/W



Symbol	Parameter	Conditions		Value			1124
Symbol	Parameter			Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$		-30			V
I _{DSS} Zero Gate Voltage Drain Current		T _J =25°C			-1		
	Zero Gate Voltage Drain Current	$V_{DS} = -30V, V_{GS} = 0V$	T _J =125°C			-25	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	•			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		-1	-1.6	-2.4	V
D	Ctatia Duain Causaa On Basistanaa	V _{GS} =-10V, I _D =-6A			43	50	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V, I _D =-6A	V _{GS} =-4.5V, I _D =-6A		66	79	mΩ
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-6A			6.7		S
V_{SD}	Diode Forward Voltage	I _S =-6A, V _{GS} =0V				-1	V
I _s	Maximum Body-Diode Continuous Cur	rrent ^B				-6	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance				651		
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =-15V, f =1MH _Z			71		pF
C _{rss}	Reverse Transfer Capacitance				64		
R_g	Gate Resistance	f =1MH _Z			7		Ω
SWITCHIN	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	$V_{GS} = -10V, V_{DS} = -15V, I_{D} = -6A$			16		
Q_{gs}	Gate Source Charge				3		nC
Q_{gd}	Gate Drain Charge				3		
t _{D(on)}	Turn-On Delay Time				10		
t _r	Turn-On Rise Time	$V_{GS} = -10V, V_{DS} = -15V, I_{D} = -6A,$ $R_{G} = 2.5\Omega$			16		ns
t _{D(off)}	Turn-Off Delay Time				17		
t _f	Turn-Off Fall Time				11		

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

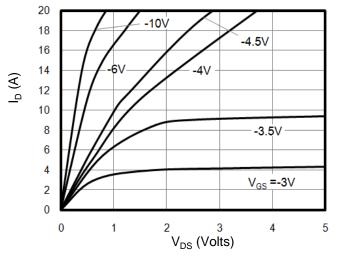


Figure 1: On-Region Characteristics

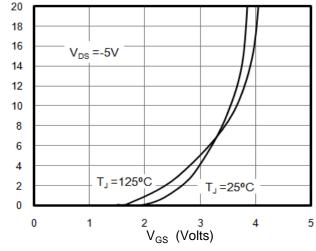


Figure 2: Transfer Characteristics

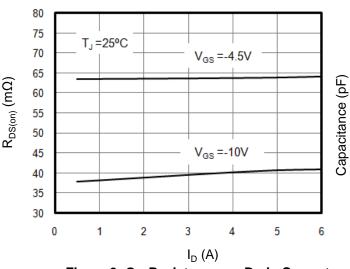


Figure 3: On-Resistance vs. Drain Current

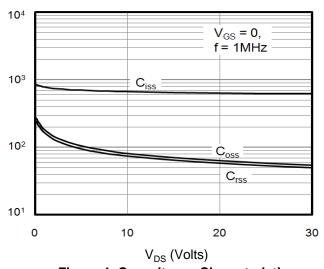


Figure 4: Capacitance Characteristics

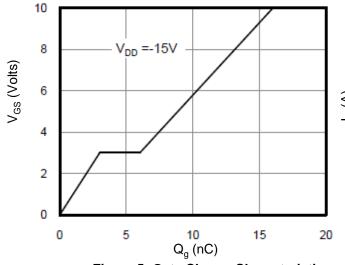


Figure 5: Gate Charge Characteristics

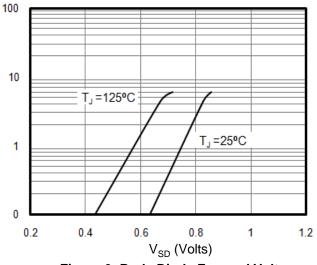
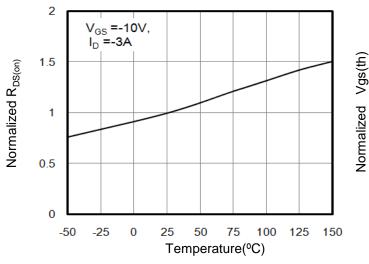


Figure 6: Body Diode Forward Voltage



 $Z_{\theta\, \text{JC}}$ Normalized Transient Thermal Resistance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



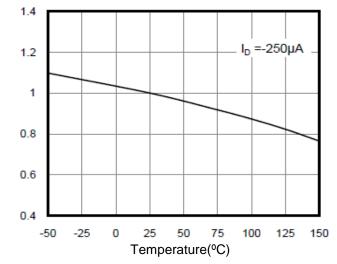
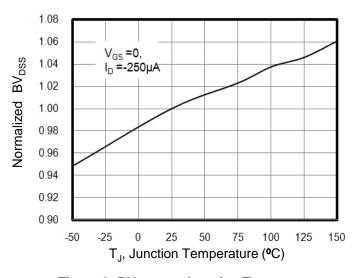


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



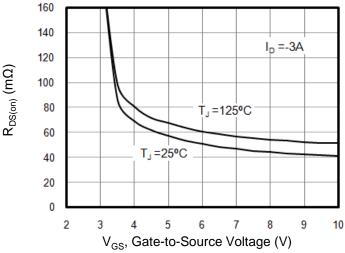
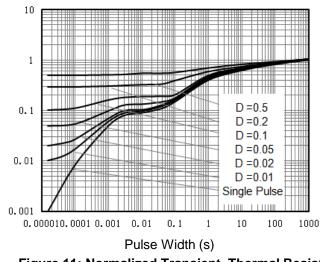


Figure 9: BV_{DSS} vs. Junction Temperature

Figure 10: On-Resistance vs. Gate-Source Voltage



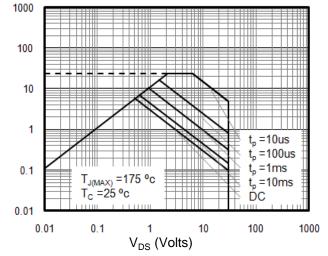


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

l_D (Amps)

Figure A: Gate Charge Test Circuit and Waveform

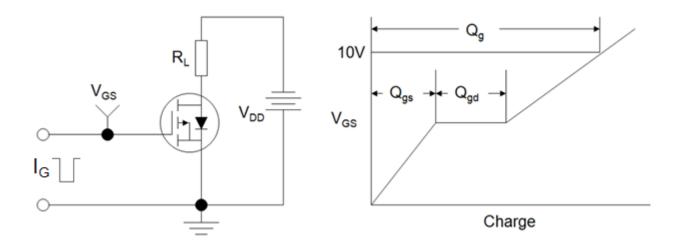


Figure B: Resistive Switching Test Circuit and Waveform

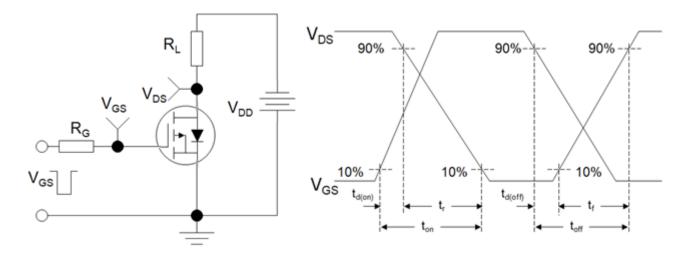
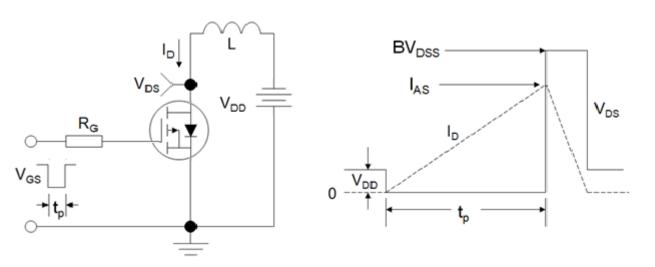
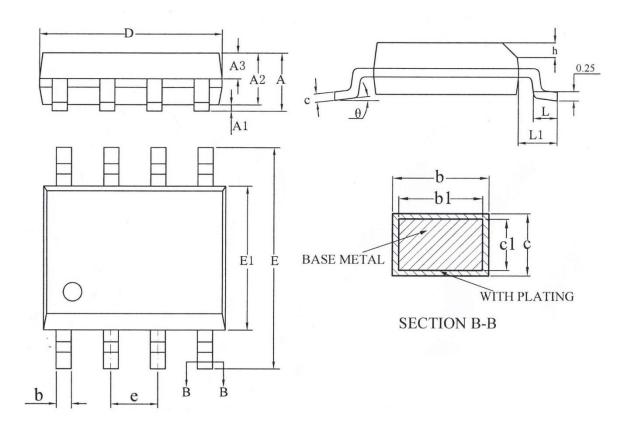


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





SOP-8



SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
A		_	1.75	
A1	0.10	_	0.225	
A2	1.30	1.40	1.50	
A3	0.60	0.65	0.70	
b	0.39	_	0.48	
bl	0.38	0.41	0.43	
С	0.21	_	0.26	
c1	0.19	0.20	0.21	

SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
D	4.70	4.90	5.10	
Е	5.80	6.00	6.20	
E1	3.70	3.90	4.10	
e	1.27BSC			
h	0.25	_	0.50	
L	0.50		0.80	
L1	1.05BSC			
θ	0		8°	



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